

Search Notes



Application/Control No.

09/933,285

Examiner

Tan Dean D. Nguyen

Applicant(s)/Patent under Reexamination

SMITH ET AL.

Art Unit

3629

SEARCHED

| Class | Subclass | Date | Examiner |
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INTERFERENCE SEARCHED

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)

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| I US | 9/05 | DN |
| 1. PG pub | | |
| 2. Patent | | |
| II FOREIGN | | |
| 1. EPO | | |
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| 4. IBM-TDB | ✓ | ✓ |
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